Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/765,917	WADA ET AL.	
Examiner	Art Unit	
Paul D. Kim	3729	

	SEAR	CHED	
Class	Subclass	Date	Examiner
29	25.01 417 592.1 593 831 842 846 854	10/10/2006	PK
324	754 755 758		
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438	14-18	. /	
427	129 130	¥	

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Text Search EAST/NPL (IEEE)	10/10/2006	PK		